

ECE 459/559

Secure & Trustworthy

Computer Hardware Design

Metrics and Security Properties
(Online)

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Recap

- Hardware security primitives discussed:

- Random Number Generators

- True Random Number Generator (TRNG)

- Pseudo Random Number Generator (PRNG)

need HW
- sensitive to noise / radioactive decay

e.g. LFSR

- Physical Unclonable Function (PUF)

- Arbiter PUF (A-PUF)

559 x • Ring Oscillator PUF (RO-PUF)

- Logic Locking Techniques

459 x • XOR-based key gate *insertion*

- LUT-based logic *replacement*

- Boosted Finite State Machine (BFSM)

- Security primitives do not offer security in and of themselves

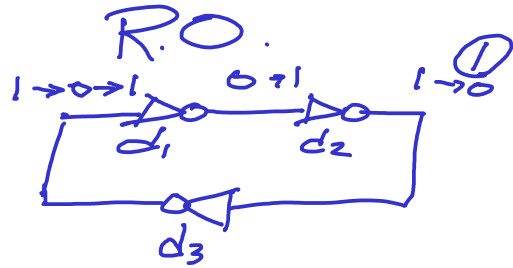
Recap

- Hardware security primitives discussed:
 - Random Number Generators
 - True Random Number Generator (TRNG)
 - Pseudo Random Number Generator (PRNG)
 - Physical Unclonable Function (PUF)
 - Arbiter PUF (A-PUF)
 - Ring Oscillator PUF (RO-PUF)
 - Logic Locking Techniques
 - XOR-based key gate *insertion*
 - LUT-based logic *replacement*
 - Boosted Finite State Machine (BFSM)
- Security primitives do not offer security in and of themselves
- They provide properties that can be utilized at higher levels of abstraction
- Security only makes sense when consider user (and attacker) interactions

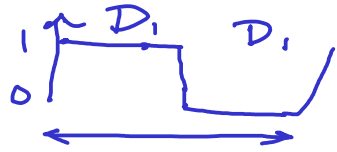
general security
metric:

time

Review – Ring Oscillator PUF



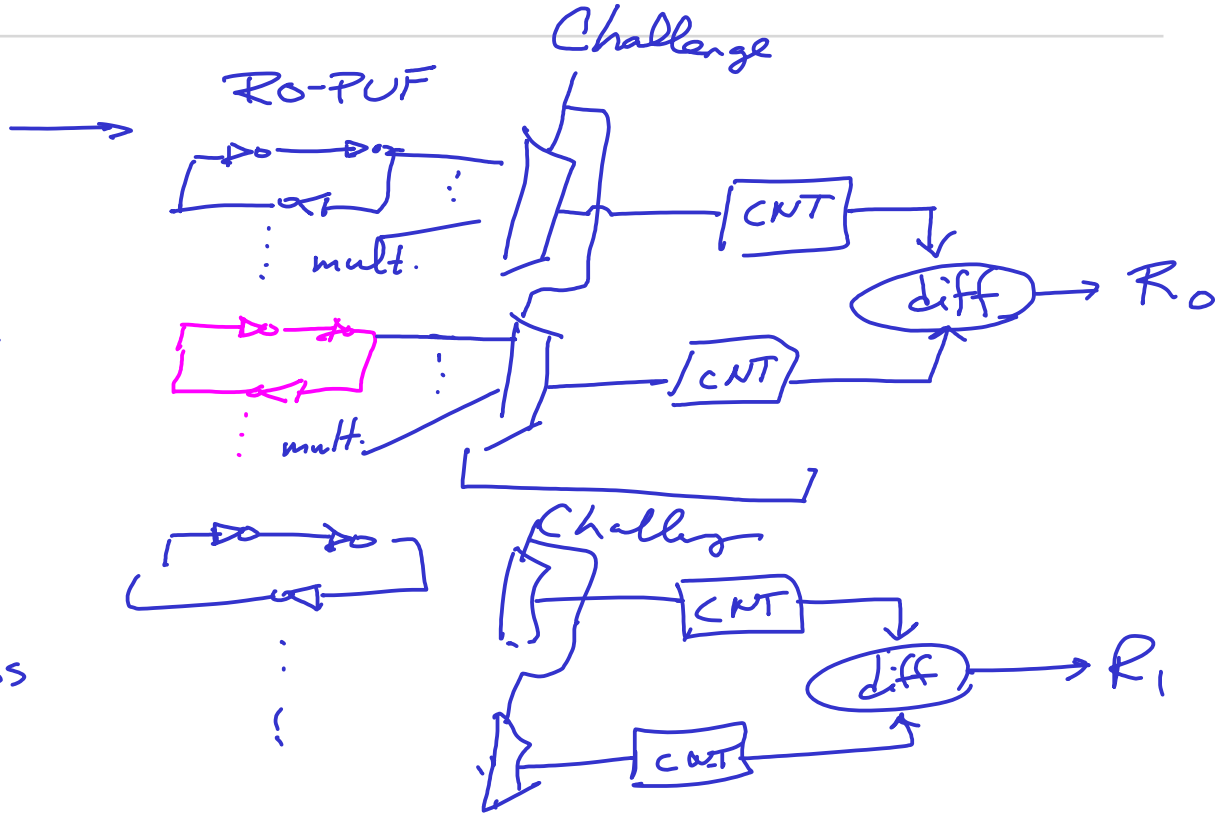
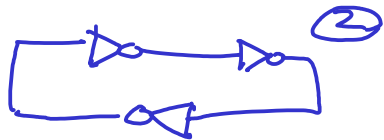
$$D_1 = d_1 + d_2 + d_3$$



$$T_1 = 2 \cdot D_1$$

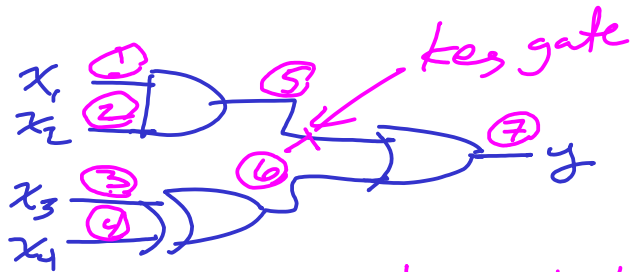
$T_1 \neq T_2$
due to var.

Uniqueness
reliable



Review – Rajendran Logic Encryption

logic locking



1) label all nodes

2) det. testability ← where
for all nodes

3) rank nodes by testability

4) insert key gates at
highest nodes

node	test.
5	0.6
3	0.5
4	0.4
6	0.3



testability
→ count the # test vec's
that allow a test on that node
for both faults

→ alt.: fault sim — HOPE

Other consideration:

of gates \rightarrow Hamming Dist

Desired Property:

Source of Entropy (Randomness)

- NIST has a suite of tests/metrics:
“A Statistical Test Suite for Random and Pseudorandom Number Generators for Cryptographic Applications”
- TRNGs and PRNGs are needed for many cryptographic algorithms and even hardware security protocols
 - E.g. EPIC active metering technique employs a TRNG for secret key generation
- High-level algorithm must assume the TRNG or PRNG works & works well
- The NIST suite includes 15 tests to determine if a RNG is “random enough”

NIST Test Suite – 15 Tests *Metrics*

- The Frequency (Monobit) Test
- Frequency Test within a Block
- The Runs Test
- Tests for Longest-Run-of-Ones in a Block
- Binary Matrix Rank Test
- Discrete Fourier Transform (Spectral) Test
- Non-overlapping Template Matching Test
- Overlapping Template Matching Test
- Maurer's "Universal Statistical" Test
- Linear Complexity Test
- The Serial Test
- Approximate Entropy Test
- Cumulative Sums (Cusums) Test
- The Random Excursions Test
- The Random Excursions Variant Test

Desired Properties: Uniqueness and Reliability

- Recall: PUFs are generally measured by two key security properties:
 - Uniqueness – variability in *space* (differences chip-to-chip)
 - Reliability – variability in *time* (differences in response on one chip)
- These properties are measured by two common metrics:
 - Inter-chip distance (aka. inter-distance) for uniqueness – Ideal: 50 % — chip-to-chip
 - Intra-chip distance (aka. Intra-distance) for reliability – Ideal: 0 % — on one chip over time
- Both are based on Hamming Distance (HD) comparisons between different challenge-response-pairs (CRPs)

Hamming Distance as a Metric

Maiti et al

- Note: this is not a full blown security measure... it helps assess the “goodness” of security primitives
- Basic definition (for inter-distance):

uniqueness

*assess over mult. chips
→ det. average*

$$Inter\ HD = \frac{1}{k(k-1)} \sum_{i=1}^{k-1} \sum_{j=i+1}^k \frac{HD(R_i, R_j)}{n}$$

$HD(R_i, R_j)$ – Number of bits different between response i and response j

n = number of bits in response R

k = number of chips considered

i and j represent two different chips

R_i = response on chip i for challenge C

R_j = response on chip j for challenge C

Other Useful Metrics for PUFs

- Bit-Aliasing
 - Measure of bits within a response that may be biased to 0 or 1
- Uniformity
 - Basically, % of bits that are 1 in average response
 - Desire 50 % – on average, we'd like same numbers of 1's and 0's
- Paper with some useful description of PUF metrics:
“Method to Evaluate Performance of PUFs” – Maiti (on Canvas)

Desired Properties: — Confusion of Outputs

Output Sensitivity and Output Corruption

- For logic locking, we considered two metrics that can help with design:
 - Testability – determine where to place key gates (assuming gate insertion)
 - Hamming Distance – determine how many key gates to place
- Testability can be thought of as a measure of how sensitive the outputs are to a change in a particular node's logic value
 - Testability is the metric
 - Security property could be thought of as output sensitivity
- Hamming distance is a measure of the average corruption of output bits when an incorrect key is supplied
 - Hamming distance is the metric
 - Security property could be thought of as output corruption

/ design parameters

Think about:

- diffusion
- avalanche effect
- uniqueness

Takeaways

- High level cryptographic algorithms and security protocols must be able to assume the security primitives are strong, and accomplish the task
 - A TRNG should be assumed to be “random” *← need to show it — use NIST*
- However, when these primitives are hardware security primitives, we must design them such that they perform as needed
- Good metrics are important in designing solid hardware security primitives
- With good metrics, we can confidently say the primitive provides the needed security properties for higher level security protocols